Re	gist	ration No :												
Tota	J Nu	ımber of Pages	s : 01	210			210			210		21	° F	B.Tech. PECS5408
211		Answer Ques	EMB	EDDE BR 1 which in the	ED SY RANC Tim Max Q.C ch is e righ	YSTE CH: Cone: 3 X Mar CODE Com nt har	M DI CSE, Hourks: : C4 puls nd m	EVEL IT, IT irs 70 67 ory a argii	OPI TE and a n ind	any F	Γ FIVE fi e marl	rom th		010
Q1.	a) b)	Answer the following questions: Short answer type:  What are the typical characteristics of an embedded system?											(2 x 10)	
21(	b) c) d) e) f) g) h) i)	What does UAF Define RTOS. What are the ap Define SoC with Draw the data f What is rate-mo Differentiate coo Define hardwar	RT contair oplications on an exam rame form onotonic s arse and f	i? <sub>10</sub> s of an apple. nat of Control chedule	embe CAN. ing? anular	edded	syste	em?		210		21		210
<b>Q2.</b>	a) b)	Explain state tra				ΓOS.	210			210		21		(5) (5)
<b>Q3.</b>	<ul> <li>a) Differentiate soft and hard RTOS.</li> <li>b) Consider the following three periodic real-time tasks to be scheduled using EDF on a uniprocessor: T<sub>1</sub> = (e<sub>1</sub> = 10, p<sub>1</sub> = 20), T<sub>2</sub> = (e<sub>2</sub> = 5, p<sub>2</sub> = 50) and T<sub>3</sub> = (e<sub>3</sub> = 10, p<sub>3</sub> = 35). Determine whether the task set is schedulable. Is EDF really a dynamic priority scheduling algorithm? Justify your answer.</li> </ul>												<b>(5) (5)</b>	
Q4.	a) b)	Explain the schedulability test for RMA. Specify the necessary and sufficient condition.  With a neat diagram explain the microkernel-based systems.											(5) (5)	
<b>Q5.</b>	a) b)	Differentiate between SRAM and DRAM.  Describe the architecture of a typical microcontroller with a neat diagram.											(5) (5)	
<b>Q6.</b>	a) b)	Explain general-purpose processor basic architecture with a neat sketch diagram. What is an application-specific integrated circuit? Explain its design and implementation.											(5) (5)	
Q7.		What do you mequirement of												(10)

Write short answer on any TWO: Q8.

(5 x 2)

a) Flash Memory

application?

- b) POSIX-RT
- c) Embedded System Development Life Cycled) Design for Testability Techniques